## Search Notes



Application/Control No.	Applicant(s)/Patent Under
	Reexamination

10661322 PARIDA ET AL.

Examiner Art Unit

PETER COUGHLAN 2129

## SEARCHED

Class	Subclass	Date	Examiner
706	@pd<20030905 and 12, 13, 15	11/29/2007	PDC
706	@ad<20030905 and @pd>20071129 and 20, 15, 16, 12, 13	5/30/2008	PDC
706	@pd<20030905 w/ permutation, pattern and 45, 46, 25, 26	11/24/2008	PDC
707	@pd<20030905 w/permutation , pattern and 100	11/24/2008	PDC

## **SEARCH NOTES**

Search Notes	Date	Examiner
East @pd<20030905 and permutation pattern, detection, balanced tree, IBM, offset, selecting, memory, substring, value, input string, characters, amino acids, genome, permutation, curve fitting, degree polynomial, binary tree	11/29/2007	PDC
IEEE <2008 and Laxmi Parida, Revital Erez, Menachem Landau, Pattern detection, permutations, window, string, balanced search tree, IBM, substring, amino acids, genome, curve fitting, degree polynomial, binary tree	11/29/2007	PDC
Dogpile – permutation patterns, detection, balanced trees, IBM, offset, selecting, memory, substring, value, input string,	11/29/2007	PDC
Inventors and Laxmi Parida, Revital Erez, Menachem Landau,	11/29/2007	PDC
East - @ad<20030905 and @pd>20071129 and permutation, pattern, input string, character, colocale, co locate, co-locate, relationship, between, group, shift input, string, window	5/30/2008	PDC
IEEE ~ <2004 and @pd>20071129 and permutation, pattern, input string, character, colocale, co locate, co-locate, relationship, between, group, shift input, string, window	11/24/2008	PDC

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 11252008A